

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/586,263	NAKADAIRA ET AL.	
Examiner		Art Unit		Page 1 of 1
JASON M. MANDEVILLE		2629		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0067423	04-2003	Suyama et al.	345/6
*	B	US-2003/0080923	05-2003	Suyama et al.	345/6
*	C	US-2003/0071765	04-2003	Suyama et al.	345/6
*	D	US-2002/0163482	11-2002	Sullivan, Alan	345/6
*	E	US-2003/0067422	04-2003	Suyama et al.	345/6
*	F	US-2002/0130820	09-2002	Sullivan, Alan	345/6
*	G	US-7,002,532	02-2006	Suyama et al.	345/6
*	H	US-4,670,744	06-1987	Buzak, Thomas S.	345/6
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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